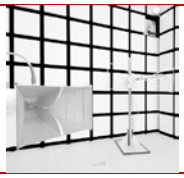
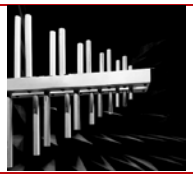
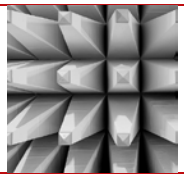

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consulting - testing - certification ➤➤➤

TEST REPORT

Test report no.: 1-9958/15-03-04-B

ilac-MRA DAkkS Deutsche Akkreditierungsstelle D-PL-12076-01-00

Testing laboratory

CETECOM ICT Services GmbH
Untertuerkheimer Strasse 6 – 10
66117 Saarbruecken / Germany
Phone: + 49 681 5 98 - 0
Fax: + 49 681 5 98 - 9075
Internet: http://www.cetecom.com
e-mail: ict@cetecom.com

Accredited Testing Laboratory:
The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)
The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-00

Applicant

Sphinx Electronics GmbH &Co. KG
Tullastr. 3
79341 Kenzingen / GERMANY
Phone: +49 764 492 280
Fax: +49 764 492 2890
Contact: Marco Bürgel
e-mail: marco.buergel@sphinx-electronics.de
Phone: +49 764 492 2851

Manufacturer

Sphinx Electronics GmbH &Co. KG
Tullastr. 3
79341 Kenzingen / GERMANY

Test standard/s

47 CFR Part 15	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 210 Issue 8	Spectrum Management and Telecommunications Radio Standards Specification - Licence-exempt Radio Apparatus (All Frequency Bands): Category I Equipment

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item:	**RFID Encoding Station**
Model name:	**ES110**
FCC ID:	**TCN013**
IC:	**5103A-013**
Frequency:	13.56 MHz
Technology tested:	RFID
Antenna:	Integrated antenna
Power supply:	4.75 V to 5.25 V DC by external power supply
Temperature range:	-20°C to +60°C

This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorized:

cn=Christoph Schneider, o=CETECOM ICT Services GmbH, ou=SND-120402, email=christoph.schneider@cetecom.com, c=DE
2016.04.14 08:42:44 +02'00'

Christoph Schneider
Testing Manager
Radio Communications & EMC

Test performed:

p.o.
cn=Andreas Luckenbill, o=CETECOM ICT Services GmbH, ou=LUC-111202, email=andreas.luckenbill@cetecom.com, c=DE
2016.04.14 07:25:20 +02'00'

Stefan Sachs
Testing Manager
Radio Communications & EMC

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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.
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This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

This test report replaces the test report with the number 1-9958/15-03-04-A and dated 2016-04-08

2.2 Application details

Date of receipt of order:	2015-06-01
Date of receipt of test item:	2015-06-02
Start of test:	2016-02-29
End of test:	2016-03-03
Person(s) present during the test:	-/-

3 Test standard/s and references

Test standard	Date	Description
47 CFR Part 15		Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 210 Issue 8	December 2010	Spectrum Management and Telecommunications Radio Standards Specification - Licence-exempt Radio Apparatus (All Frequency Bands): Category I Equipment

Guidance	Version	Description
ANSI C63.4-2014	-/-	American national standard for methods of measurement of radio-noise emissions from low-voltage electrical and electronic equipment in the range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American national standard of procedures for compliance testing of unlicensed wireless devices

4 Test environment

Temperature	:	T_{nom} T_{max} T_{min}	+22 °C during room temperature tests +60 °C during high temperature tests -20 °C during low temperature tests
Relative humidity content	:		55 %
Barometric pressure	:		not relevant for this kind of testing
Power supply	:	V_{nom} V_{max} V_{min}	5.0 V DC by external power supply 5.25 V 4.75 V

5 Test item

5.1 General description

Kind of test item	:	RFID Encoding Station
Type identification	:	ES110
HMN	:	-/-
PMN	:	ES110
HVIN	:	ES110
FVIN	:	-/-
S/N serial number	:	13143159
HW hardware status	:	1.2
SW software status	:	0.3.5
Frequency band	:	13.56 MHz
Type of radio transmission Use of frequency spectrum	: :	single carrier
Type of modulation	:	NON
Number of channels	:	1
Antenna	:	Integrated antenna
Power supply	:	4.75 V to 5.25 V DC by external power supply
Temperature range	:	-20°C to +60°C

5.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report: 1-9958/15-03-01_AnnexA
1-9958/15-03-01_AnnexB
1-9958/15-03-01_AnnexD

6 Test laboratories sub-contracted

None

7 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

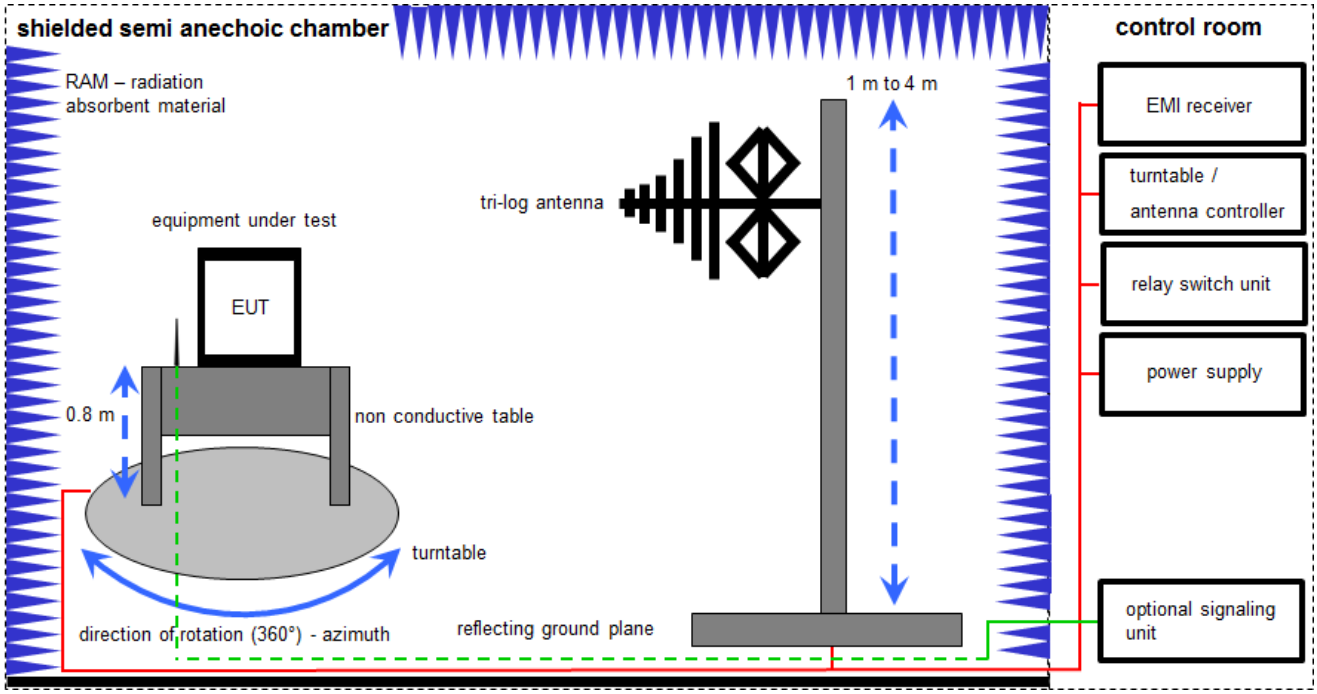
In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
vlkl!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

7.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Measurement distance: tri-log antenna 10 meter

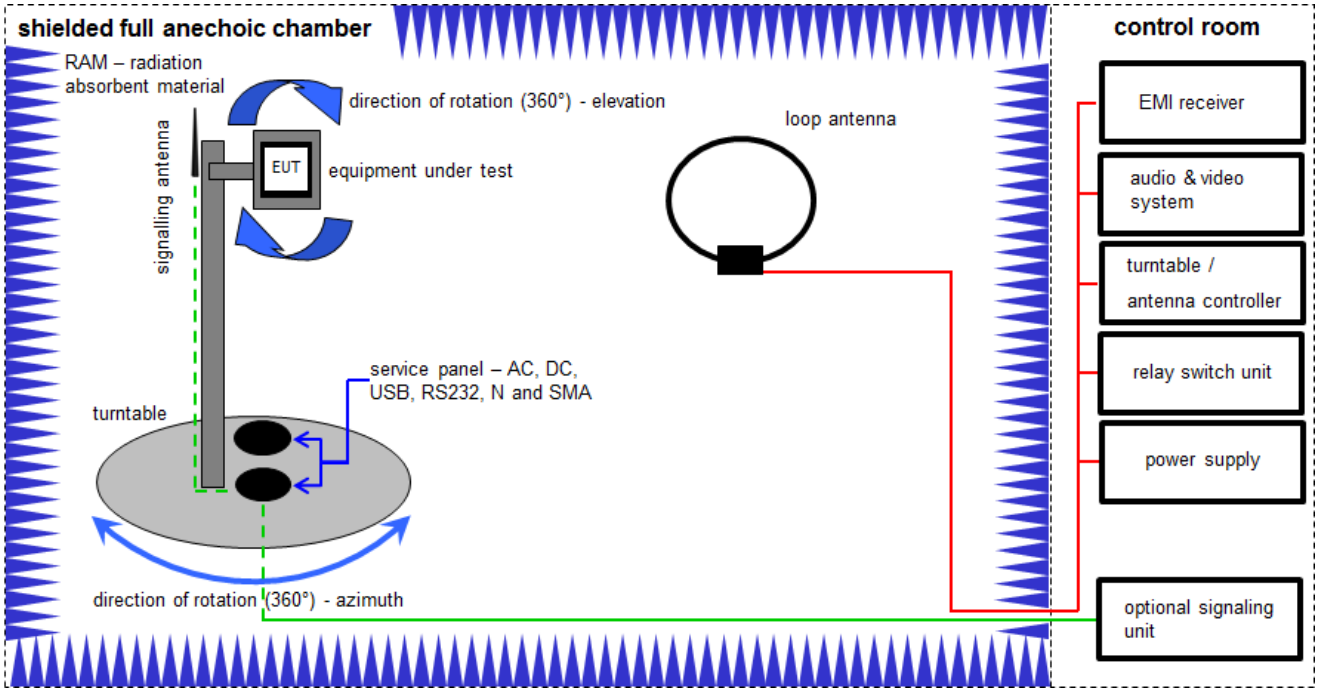
FS = UR + CL + AF
(FS-field strength; UR-voltage at the receiver; CL-loss of the cable; AF-antenna factor)

Example calculation:
FS [dBµV/m] = 12.35 [dBµV/m] + 1.90 [dB] + 16.80 [dB/m] = 31.05 [dBµV/m] (35.69 µV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch-Unit	3488A	HP	2719A14505	300000368	ev	-/-	-/-
2	A	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2920A04466	300000580	ne	-/-	-/-
3	A	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	27.01.2016	26.01.2017
4	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
5	A	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw	-/-	-/-
6	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
7	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	22.04.2014	22.04.2016

7.2 Shielded fully anechoic chamber



Measurement distance: loop antenna 3 meter

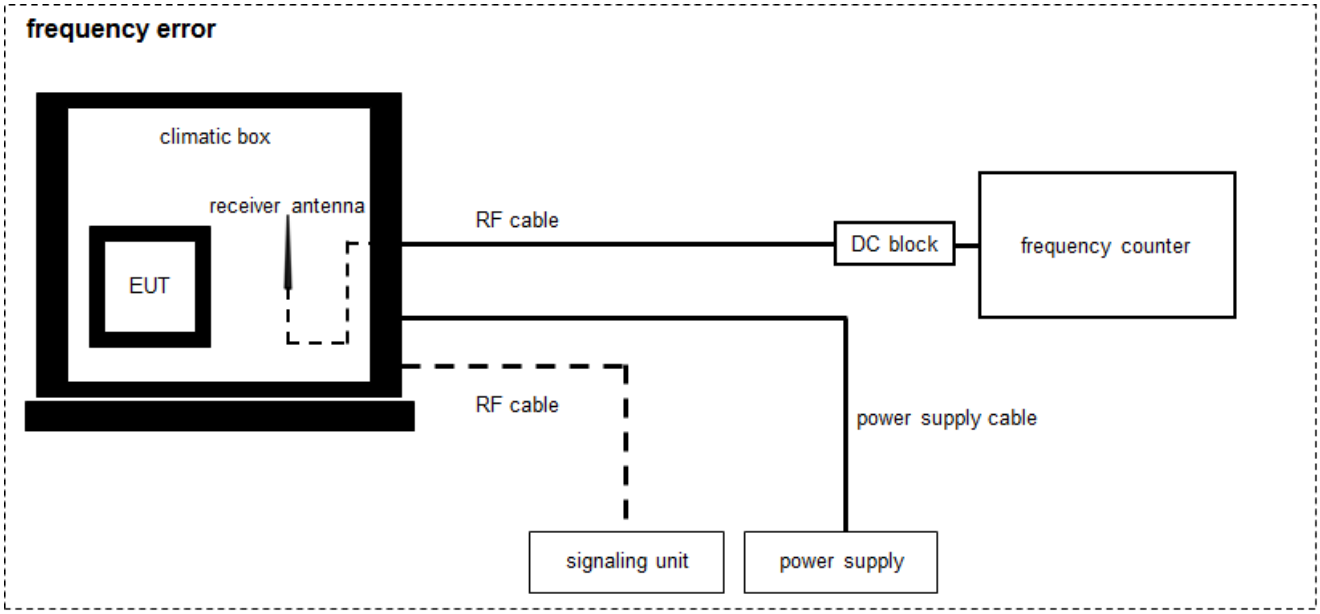
FS = UR + CA + AF
(FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

Example calculation:
FS [dBµV/m] = 40.0 [dBµV/m] + (-35.8) [dB] + 32.9 [dB/m] = 37.1 [dBµV/m] (71.61 µV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2818A03450	300001040	Ve	20.01.2015	20.01.2018
2	A	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev	-/-	-/-
3	A	Switch / Control Unit	3488A	HP	*	300000199	ne	-/-	-/-
4	A	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO/2	8905-2342	300000256	k	24.06.2015	24.06.2017
5	A	Amplifier	js42-00502650-28-5a	Parzich GMBH	928979	300003143	ne	-/-	-/-
6	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	371	300003854	vlKl!	29.10.2014	29.10.2017
7	A	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000037	300004509	ne	-/-	-/-
8	A	EMI Test Receiver 9kHz-26,5GHz	ESR26	R&S	101376	300005063	k	04.09.2015	04.09.2016

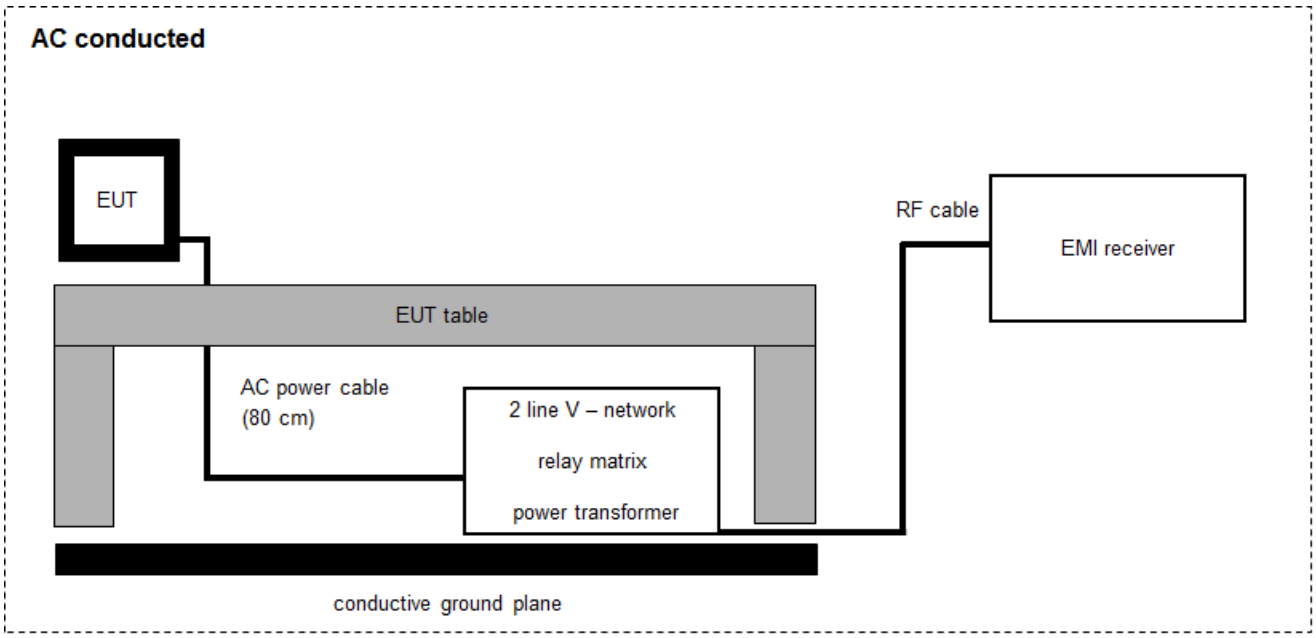
7.3 Frequency error



Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	DC Power Supply 0 – 32V	1108-32	Heiden Elektronik	001802	300001383	Ve	29.01.2014	29.01.2017
2	A	Signal Analyzer 20Hz-26,5GHz-150 to + 30 DBM	FSiQ26	R&S	835111/0004	300002678	Ve	22.01.2015	22.01.2017
3	A	Temperature Test Chamber	T-40/50	CTS GmbH	064023	300003540	ev	03.09.2015	03.09.2017
4	A	Spectrum Analyzer 9kHz to 30GHz - 140..+30dBm	FSP30	R&S	100886	300003575	k	26.08.2014	26.08.2016

7.4 AC conducted



FS = UR + CF + VC
(FS-field strength; UR-voltage at the receiver; CR-loss of the cable and filter; VC-correction factor of the ISN)

Example calculation:
FS [dBµV/m] = 37.62 [dBµV/m] + 9.90 [dB] + 0.23 [dB] = 47.75 [dBµV/m] (244.06 µV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Two-line V-Network (LISN) 9 kHz to 30 MHz	ESH3-Z5	R&S	892475/017	300002209	k	17.06.2014	17.06.2016
2	A	MXE EMI Receiver 20 Hz to 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	k	06.03.2015	06.03.2016
3	A	software	SPS_PHE 1.4f	Spitzenberger & Spiess	B5981; 5D1081;B5979	300000210	ne	-/-	-/-

8 Sequence of testing

8.1 Sequence of testing radiated spurious 9 kHz to 30 MHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1.5 m.
- At each turntable position the analyzer sweeps with positive-peak detector to find the maximum of all emissions.

Final measurement

- Identified emissions during the premeasurement are maximized by the software by rotating the turntable from 0° to 360°. In case of the 2-axis positioner is used the elevation axis is also rotated from 0° to 360°.
- The final measurement is done in the position (turntable and elevation) causing the highest emissions with quasi-peak (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. A plot with the graph of the premeasurement and the limit is stored.

8.2 Sequence of testing radiated spurious 30 MHz to 1 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 10 m or 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 m to 3 m.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximize the peaks by changing turntable position ± 45° and antenna height between 1 and 4 m.
- The final measurement is done with quasi-peak detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

9 Measurement uncertainty

Measurement uncertainty	
Test case	**Uncertainty**
Spectrum bandwidth	± 21.5 kHz absolute; ± 15.0 kHz relative
Maximum output power	± 1 dB
Spurious emissions radiated below 30 MHz	± 3 dB
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB
Frequency error	± 10 Hz

10 Summary of measurement results

☒	No deviations from the technical specifications were ascertained
☐	There were deviations from the technical specifications ascertained
☐	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS 210 Issue 8 RSS Gen Issue 4	See table!	2016-04-12	-/-

Test specification clause	Test case	Temperature conditions	Power source conditions	C	NC	NA	NP	Remark
RSS Gen Issue 4	Occupied bandwidth	Nominal	Nominal	☒	☐	☐	☐	-/-
§ 15.225 (a)	Field strength of the fundamental	Nominal	Nominal	☒	☐	☐	☐	-/-
§ 15.209 & § 15.225 (b-d)	Field strength of the harmonics and spurious	Nominal	Nominal	☒	☐	☐	☐	-/-
§ 15.109	Receiver spurious emissions and cabinet radiations	Nominal	Nominal	☐	☐	☒	☐	Collocated transmitter
§15.107 §15.207	Conducted limits	Nominal	Nominal	☒	☐	☐	☐	-/-
§ 15.225 (a)	Frequency tolerance	Normal & extreme conditions	Normal & extreme conditions	☒	☐	☐	☐	-/-

Note:

C	Compliant
NC	Not compliant
NA	Not applicable
NP	Not performed

11 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: None

12 Measurement results

12.1 Occupied bandwidth

Measurement:

The emission bandwidth (x dB) is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated x dB below the maximum in-band spectral density of the modulated signal.

Measurement parameters	
Detector:	Peak
Resolution bandwidth:	1 % – 5 % of the occupied bandwidth
Video bandwidth:	≥ 3x RBW
Trace mode:	Max hold
Analyser function:	99 % power function
Used equipment:	See chapter 7.3A
Measurement uncertainty:	See chapter 9

Limit:

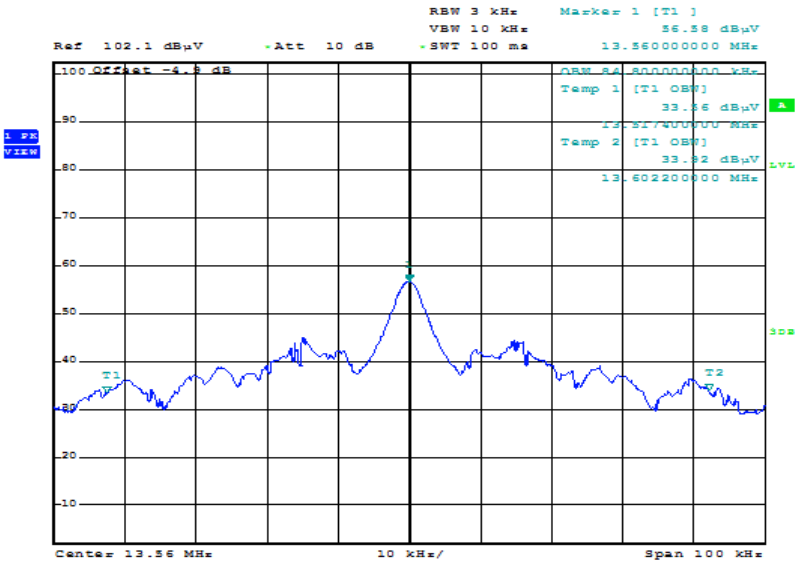
IC
for RSP-100 test report coversheet only

Result:

99% emission bandwidth
84.8 kHz

Plot:

Plot 1: 99 % emission bandwidth



Date: 1.MAR.2016 15:18:15

12.2 Field strength of the fundamental

Measurement:

The maximum detected field strength for the carrier signal.

Measurement parameters	
Detector:	Quasi peak / peak (worst case)
Resolution bandwidth:	120 kHz
Video bandwidth:	≥ 3x RBW
Trace mode:	Max hold
Used equipment:	See chapter 7.2A and 7.1A
Measurement uncertainty:	See chapter 9

Limit:

FCC & IC		
Frequency (MHz)	Field strength (µV/m)	Measurement distance (m)
13.553 to 13.567	15,848 (84 dBµV/m)	30

Recalculation:

According to ANSI C63.10		
Frequency	Formula	Correction value
13.56 MHz	$FS_{limit} = FS_{max} - 40\log\left(\frac{d_{nearfield}}{d_{measure}}\right) - 20\log\left(\frac{d_{limit}}{d_{nearfield}}\right)$ FS_{limit} is the calculation of field strength at the limit distance, expressed in dBµV/m FS_{max} is the measured field strength, expressed in dBµV/m $d_{near\ field}$ is the λ/2π distance $d_{measure}$ is the distance of the measurement point from EUT d_{limit} is the reference limit distance	-21.39

According to ANSI C63.10

Result:

Field strength of the fundamental		
Frequency	13.56 MHz	
Distance	@ 3 m	@ 30 m
Measured / calculated value	56.80 dBµV/m	35.41 dBµV/m

12.3 Field strength of the harmonics and spurious

Measurement:

The maximum detected field strength for the harmonics and spurious.

Measurement parameters	
Detector:	Quasi peak / average or peak (worst case – pre-scan)
Resolution bandwidth:	F < 150 kHz: 200 Hz 150 kHz < F < 30 MHz: 9 kHz 30 MHz < F < 1 GHz: 120 kHz
Video bandwidth:	F < 150 kHz: 1 kHz 150 kHz < F < 30 MHz: 100 kHz 30 MHz < F < 1 GHz: 300 kHz
Trace mode:	Max hold
Used equipment:	See chapter 7.2A
Measurement uncertainty:	See chapter 9

Limit:

FCC & IC		
Frequency (MHz)	Field strength (dBµV/m)	Measurement distance (m)
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30	30 (29.5 dBµV/m)	30
30 – 88	100 (40 dBµV/m)	3
88 – 216	150 (43.5 dBµV/m)	3
216 – 960	200 (46 dBµV/m)	3

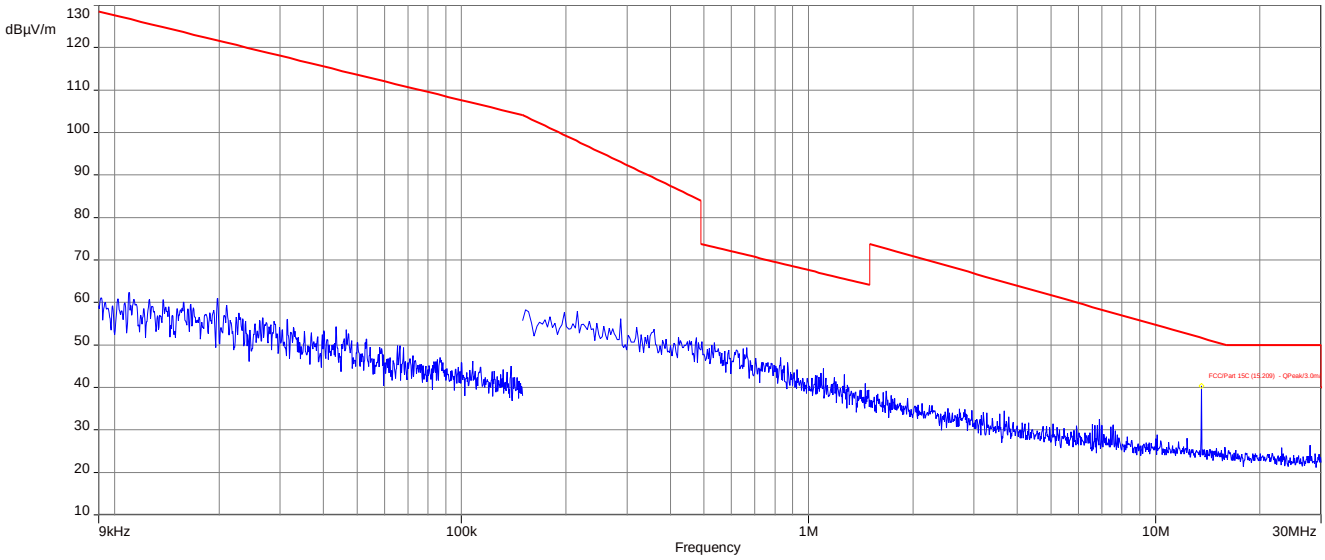
Note: For a reduced measurement distance, please take a look at the limit line and the ANSI C63.10-2013 sub clause 6.4 radiated emissions from unlicensed wireless devices below 30 MHz.

Result:

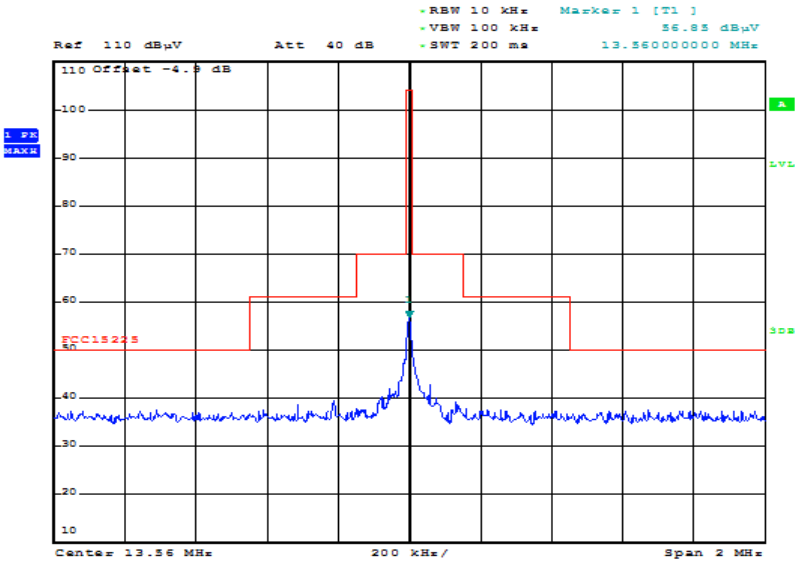
Detected emissions			
Frequency (MHz)	Detector	Resolution bandwidth (kHz)	Detected value
No emissions closer than 10 dB to the limit.			

Plots:

Plot 1: 9 kHz – 30 MHz, magnetic emissions



Plot 2: Spectrum mask (the limits are recalculated according to the ANSI C63.10-2013 sub clause 6.4)



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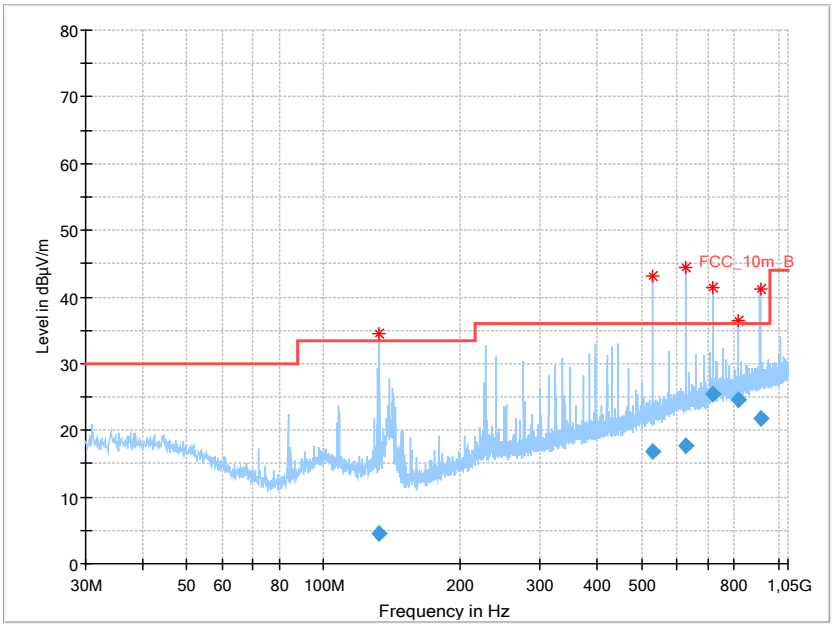
Plot 3: 30 MHz – 1 GHz, vertical and horizontal polarisation



Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
132.567000	4.54	33.50	28.96	1000.0	120.000	170.0	V	261.0	9.2
528.160050	16.78	36.00	19.22	1000.0	120.000	170.0	H	197.0	19.0
624.148050	17.68	36.00	18.32	1000.0	120.000	101.0	H	124.0	20.9
719.957850	25.40	36.00	10.60	1000.0	120.000	101.0	H	197.0	22.0
816.023850	24.63	36.00	11.37	1000.0	120.000	98.0	H	197.0	23.0
912.308700	21.77	36.00	14.23	1000.0	120.000	170.0	H	197.0	24.1

12.4 Conducted limits

Measurement:

Measurement of the conducted spurious emissions for an intentional radiator that is designed to be connected to the public utility (AC) power line.

Measurement parameters	
Detector:	Quasi peak / average or peak (worst case – pre-scan)
Resolution bandwidth:	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth:	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Trace mode:	Max hold
Used equipment:	See chapter 7.4A
Measurement uncertainty:	See chapter 9

Limit:

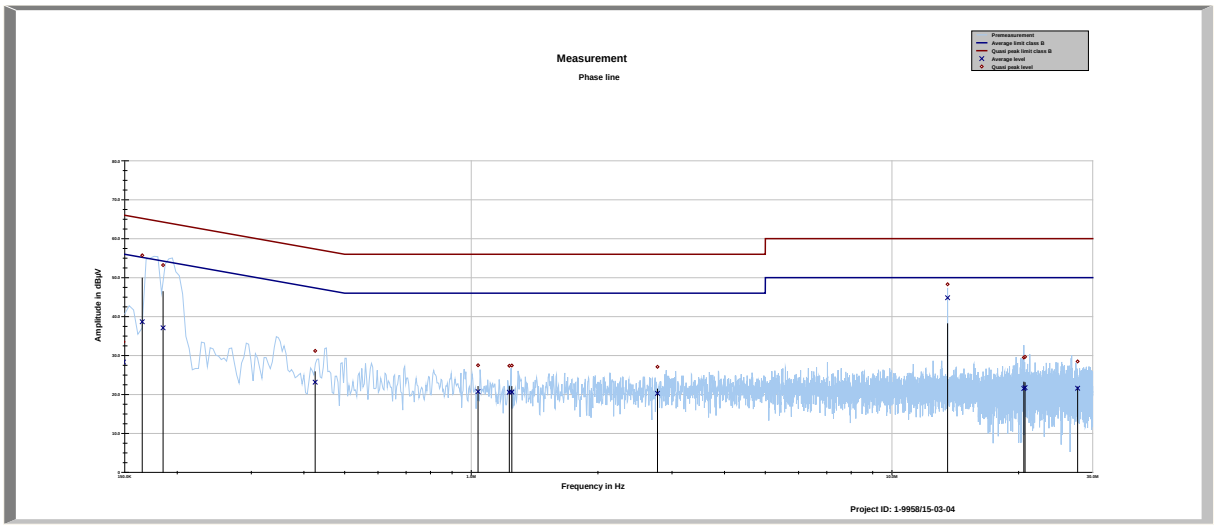
FCC & IC		
Frequency (MHz)	Quasi-peak (dBµV/m)	Average (dBµV/m)
0.15 – 0.5	66 to 56*	56 to 46*
0.5 – 5	56	46
5 – 30.0	60	50

Result:

Detected emissions			
Frequency (MHz)	Detector	Resolution bandwidth (kHz)	Detected value
See plots and tables below			

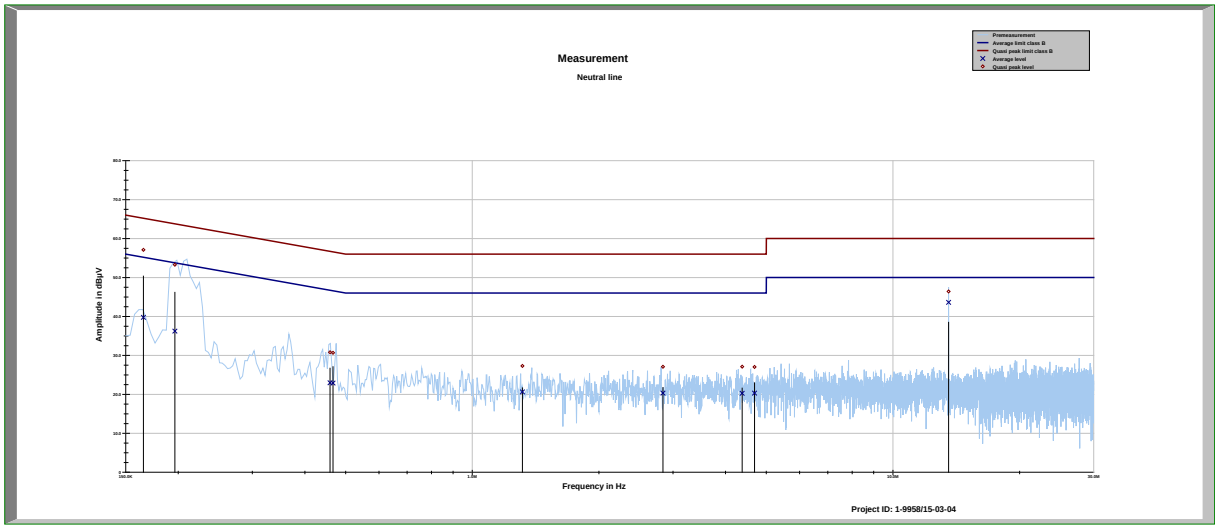
Plots:

Plot 1: 150 kHz to 30 MHz, phase line



Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dBµV	dB	dBµV	dBµV	dB	dBµV
0.165089	55.72	9.49	65.204	38.67	16.90	55.569
0.185111	53.22	11.03	64.253	37.10	17.90	54.997
0.425540	31.18	26.16	57.339	23.15	24.98	48.127
1.037859	27.51	28.49	56.000	20.73	25.27	46.000
1.231319	27.36	28.64	56.000	20.56	25.44	46.000
1.248507	27.43	28.57	56.000	20.62	25.38	46.000
2.770614	27.10	28.90	56.000	20.29	25.71	46.000
13.560115	48.28	11.72	60.000	44.82	5.18	50.000
20.580120	29.48	30.52	60.000	21.52	28.48	50.000
20.715630	29.65	30.35	60.000	21.75	28.25	50.000
27.629460	28.48	31.52	60.000	21.59	28.41	50.000

Plot 2: 150 kHz to 30 MHz, neutral line



Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dBµV	dB	dBµV	dBµV	dB	dBµV
0.165326	57.10	8.10	65.192	39.77	15.79	55.562
0.196376	53.26	10.50	63.762	36.23	18.45	54.675
0.459045	30.79	25.92	56.710	22.95	24.22	47.170
0.466535	30.65	25.93	56.575	22.88	24.07	46.956
1.315674	27.29	28.71	56.000	20.61	25.39	46.000
2.839831	27.07	28.93	56.000	20.31	25.69	46.000
4.381753	27.08	28.92	56.000	20.26	25.74	46.000
4.687591	27.03	28.97	56.000	20.31	25.69	46.000
13.557810	46.41	13.59	60.000	43.61	6.39	50.000

12.5 Frequency error

Measurement:

The maximum detected field strength for the spurious.

Measurement parameters	
Detector:	Peak detector
Resolution bandwidth:	100 Hz
Video bandwidth:	> RBW
Trace mode:	Max hold
Used equipment:	See chapter 7.3A
Measurement uncertainty:	See chapter 9

Limit:

FCC
The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of -20 degrees to +60 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C. (±1.356 kHz)

Result: Temperature variation

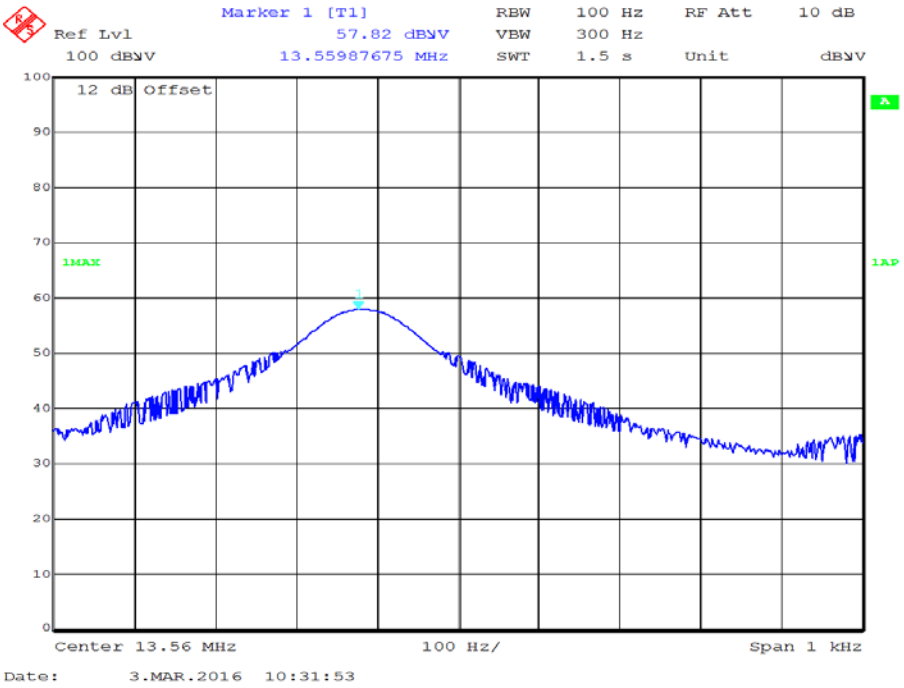
Frequency tolerance		
Measured frequency (MHz)	Conditions	Result
13.559974	-20 °C & 100% voltage	complies
13.559932	-10 °C & 100% voltage	complies
13.559976	0 °C & 100% voltage	complies
13.559962	+10 °C & 100% voltage	complies
13.559928	+20 °C & 100% voltage	complies
13.559894	+30 °C & 100% voltage	complies
13.559866	+40 °C & 100% voltage	complies
13.559874	+50 °C & 100% voltage	complies
13.559876	+60 °C & 100% voltage	complies

Result: Voltage variation

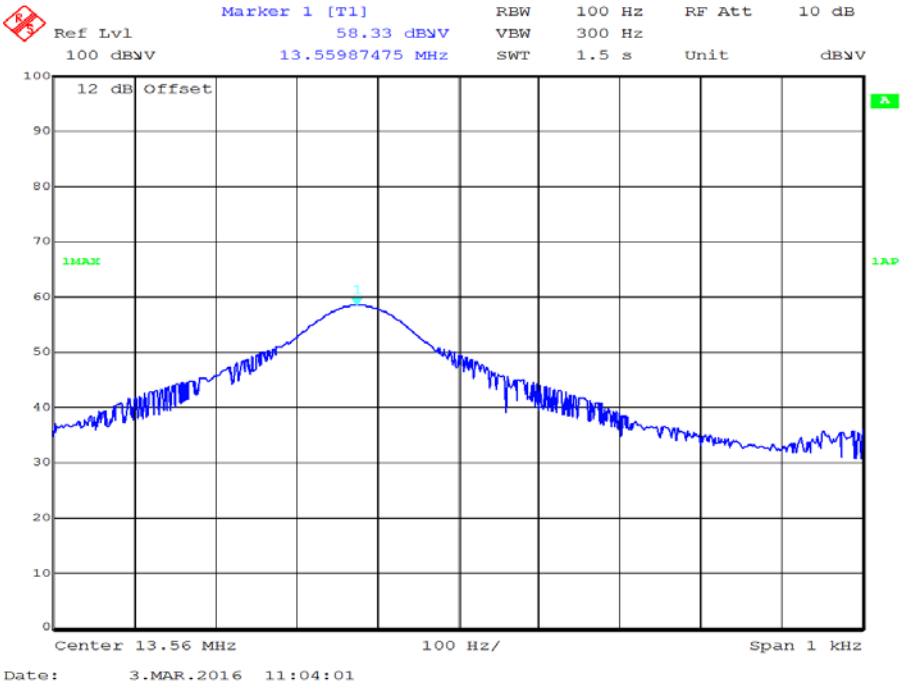
Frequency tolerance		
Measured frequency (MHz)	Temperature	Result
13.559924	+20 °C & 85% voltage	complies
13.559928	+20 °C & 100% voltage	complies
13.559918	+20 °C & 115% voltage	complies

Plots:

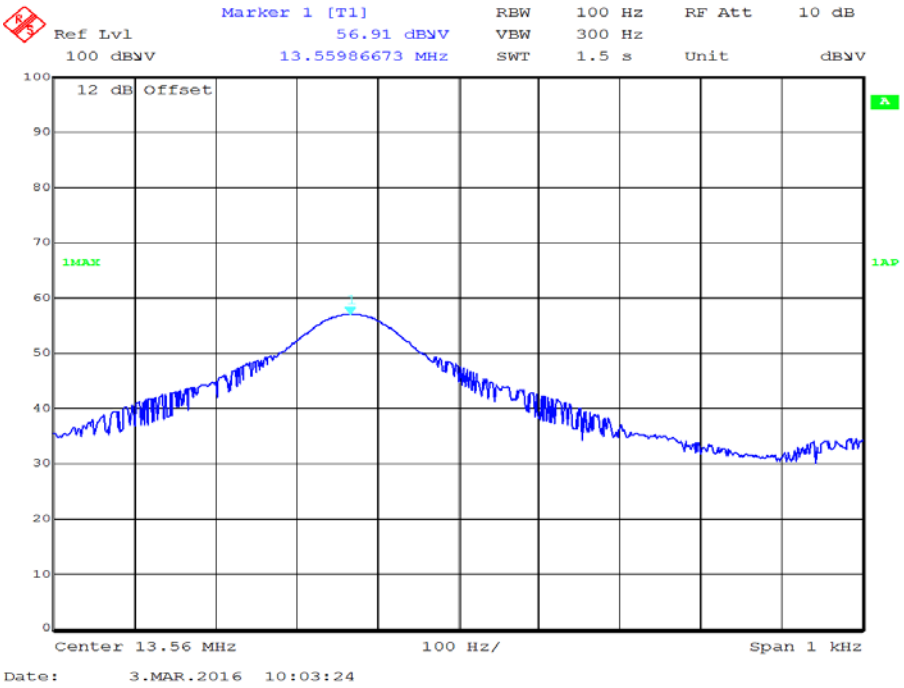
Plot 1: 100% voltage; 60°C



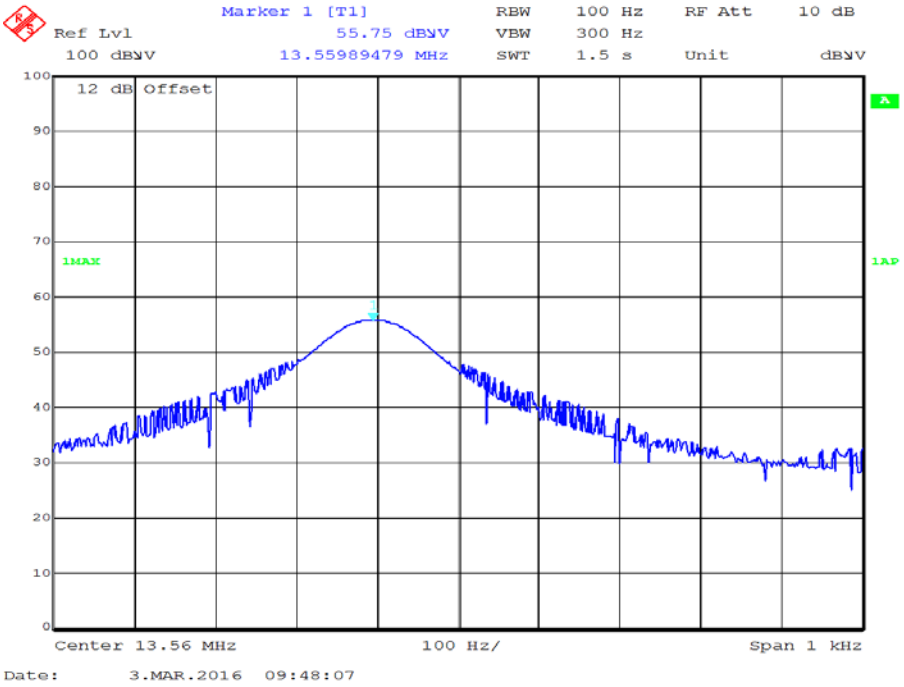
Plot 2: 100% voltage; 50°C



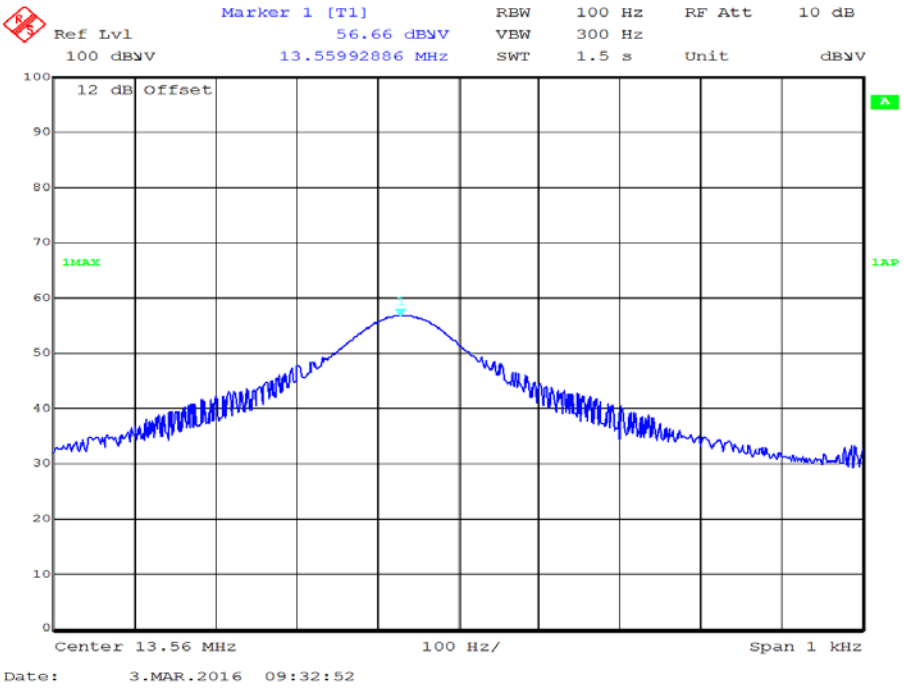
Plot 3: 100% voltage; 40°C



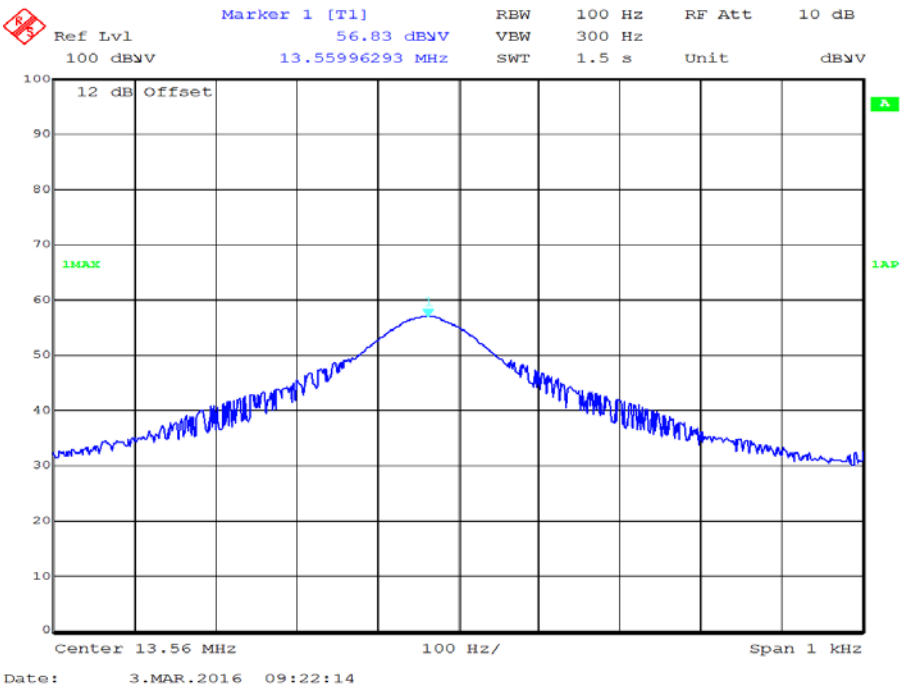
Plot 4: 100% voltage; 30°C



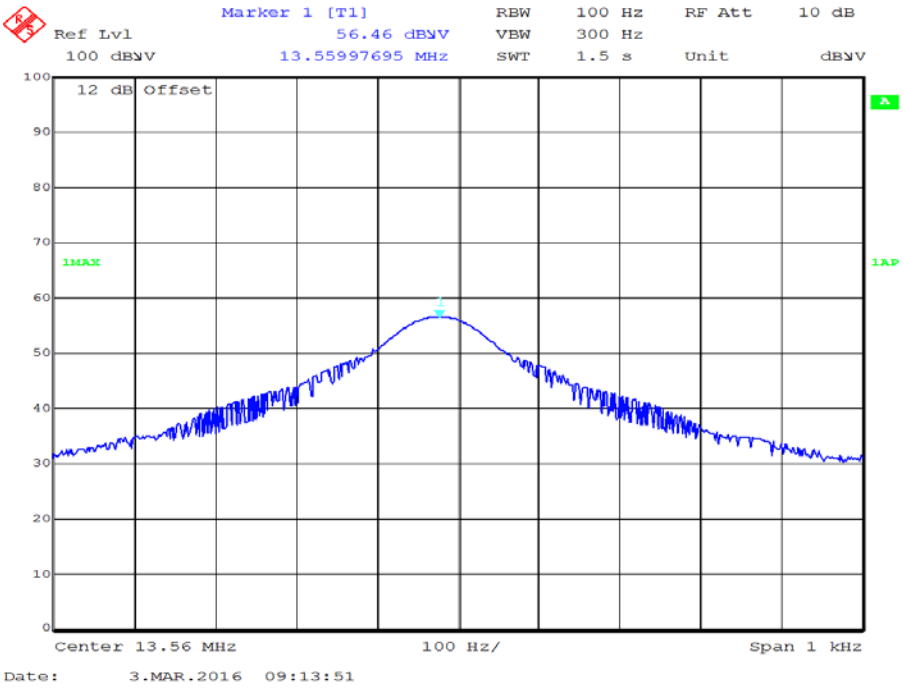
Plot 5: 100% voltage; 20°C



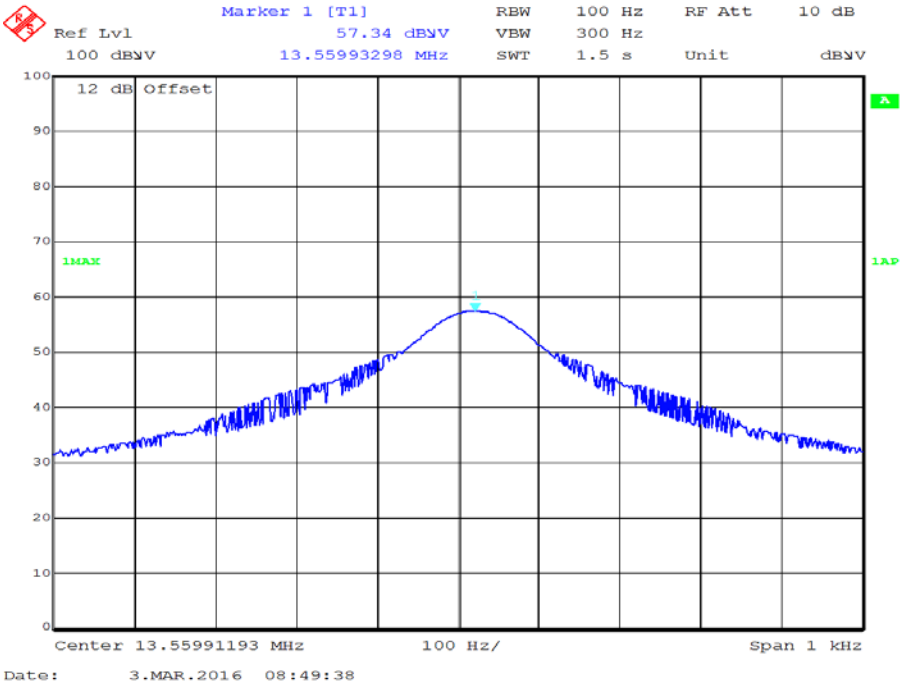
Plot 6: 100% voltage; 10°C



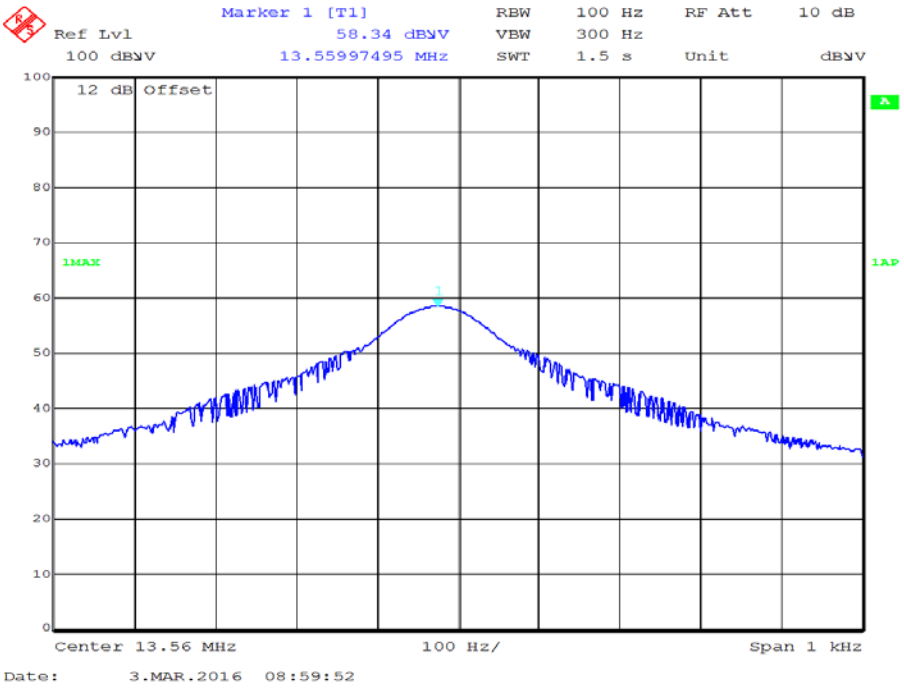
Plot 7: 100% voltage; 0°C



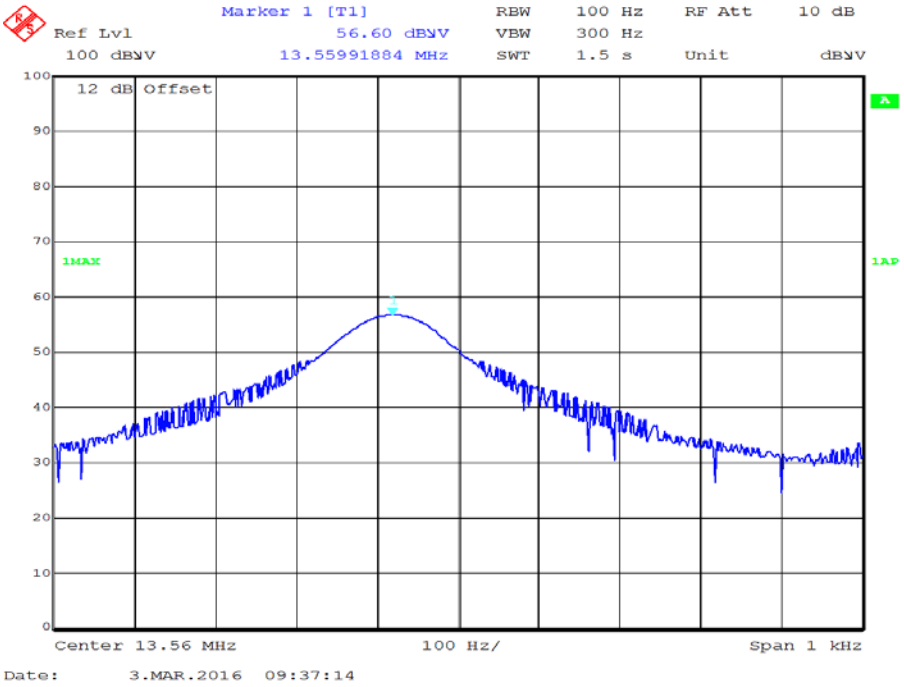
Plot 8: 100% voltage; -10°C



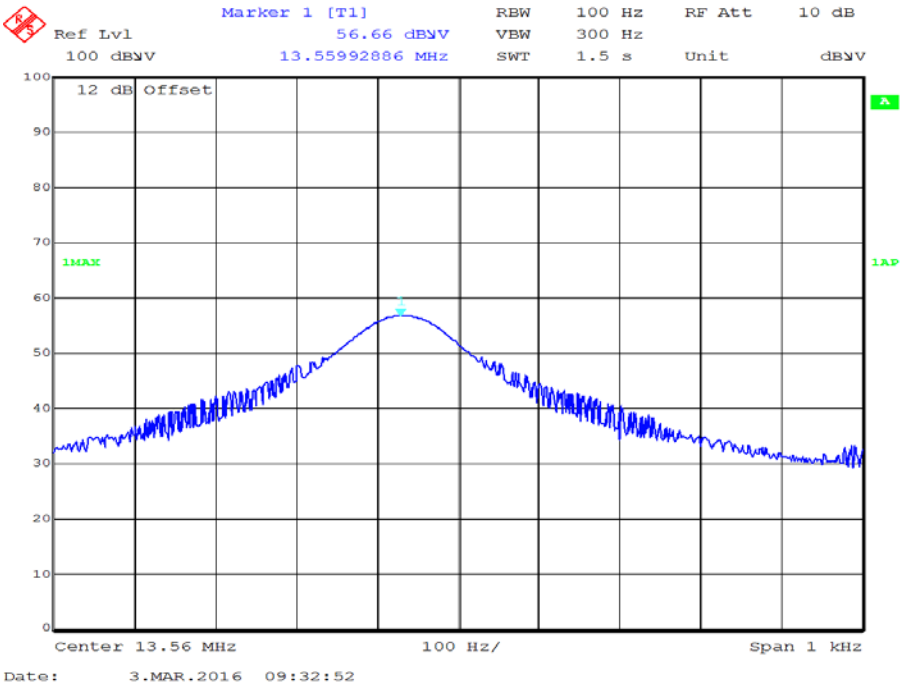
Plot 9: 100% voltage; -20°C



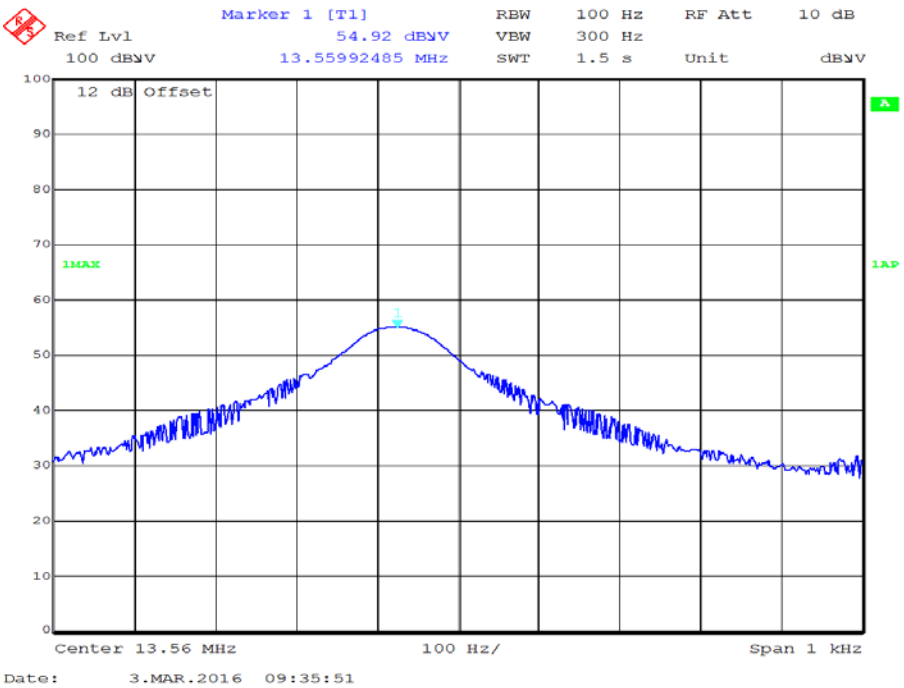
Plot 10: 115% voltage; 20°C



Plot 11: 100% voltage; 20°C



Plot 12: 85% voltage; 20°C



Annex A Document history

Version	Applied changes	Date of release
	Initial release	2016-03-14
A	Editorial changes	2016-04-08
B	Editorial changes	2016-04-12

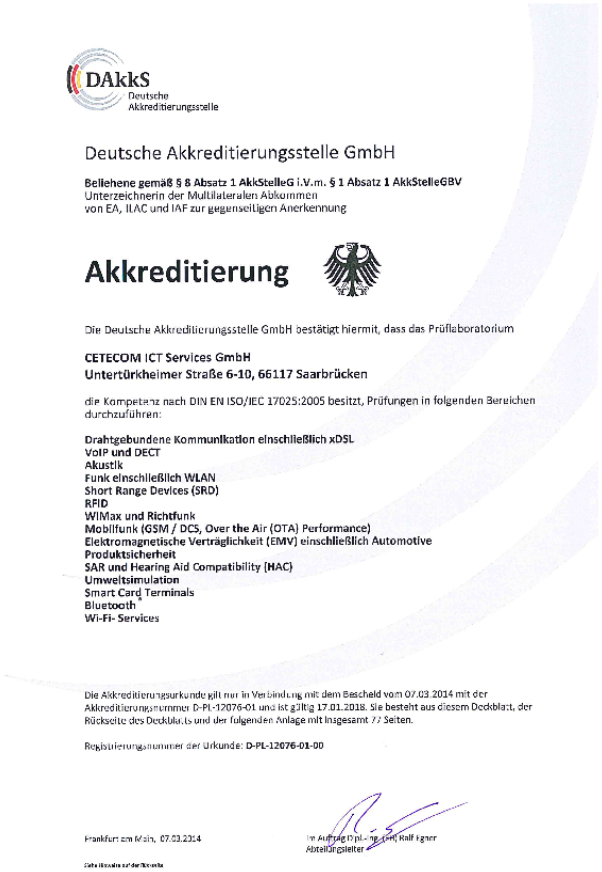
Annex B Further information

Glossary

AVG - Average
DUT - Device under test
EMC - Electromagnetic Compatibility
EN - European Standard
EUT - Equipment under test
ETSI - European Telecommunications Standard Institute
FCC - Federal Communication Commission
FCC ID - Company Identifier at FCC
HW - Hardware
IC - Industry Canada
Inv. No. - Inventory number
N/A - Not applicable
PP - Positive peak
QP - Quasi peak
S/N - Serial number
SW - Software
PMN - Product marketing name
HMN - Host marketing name
HVIN - Hardware version identification number
FVIN - Firmware version identification number

Annex C Accreditation Certificate

Front side of certificate



DAkkS
Deutsche Akkreditierungsstelle

Deutsche Akkreditierungsstelle GmbH

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CETECOM ICT Services GmbH
Untertürkheimer Straße 6-10, 66117 Saarbrücken

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VoIP und DECT
Akustik
Funk einschließlich WLAN
Short Range Devices (SRD)
RFID
WiMax und Richtfunk
Mobilfunk (GSM / DCS, Over the Air (OTA) Performance)
Elektromagnetische Verträglichkeit (EMV) einschließlich Automotive
Produktsicherheit
SAR und Hearing Aid Compatibility (HAC)
Umweltsimulation
Smart Card Terminals
Bluetooth
Wi-Fi- Services

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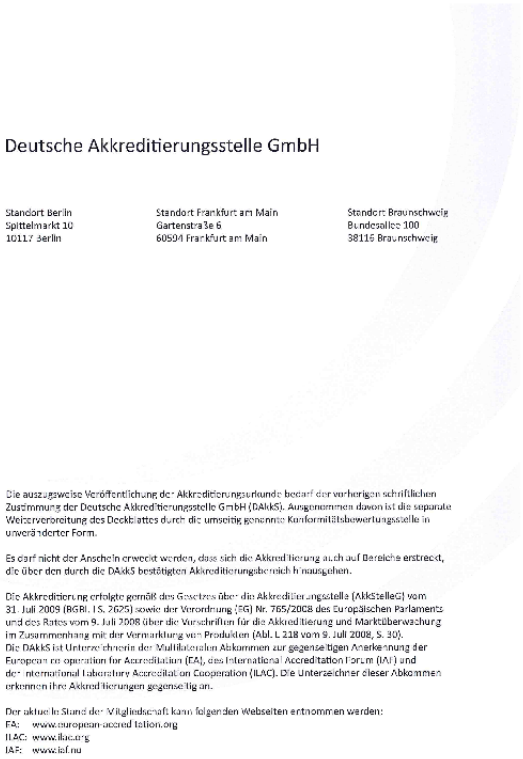
Frankfurt am Main, 07.03.2014

Im Auftrag Dipl.-Ing. (FH) Rolf Egner
Abteilungsleiter

Back side of certificate



Deutsche Akkreditierungsstelle GmbH

Standort Berlin
Spittelmarkt 10
10117 Berlin

Standort Frankfurt am Main
Gartenstraße 6
60594 Frankfurt am Main

Standort Braunschweig
Bundesallee 100
38116 Braunschweig

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